


<b>Search Notes</b>  	<b>Application/Control No.</b>  10591016	<b>Applicant(s)/Patent Under Reexamination</b>  SANO ET AL.
	<b>Examiner</b>  STEPHAN ESSEX	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
429	40, 41, 42, 43, 44	7/17/2009	SJE
502	101	7/17/2009	SJE

SEARCH NOTES		
Search Notes	Date	Examiner
EAST see search history	7/17/2009	SJE
Inventor search	7/17/2009	SJE
Consulted Dah-Wei Yuan and Jonathan Crepeau	7/17/2009	SJE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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